Impact of Proximity Effects on Sheath Losses in Trefoil Cable Arrangements

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Abstract -- Induced losses are a significant part of the total losses generated in HVAC cables. Presently, IEC 60287-1-1 is used to calculate the ratio of induced loss in a cable's metal sheath to its conductor loss (λ_1) , assuming uniform current density in both conductors and sheaths. Although this assumption is reasonable for smaller cables, it is questionable for larger cables in close proximity, such as three-core (3C) export cables in Offshore Wind Farm (OWF) projects. The effects of this non-uniform current density cannot be easily treated via a straightforward, purely analytical approach, since conductor currents are not effectively represented by linear ones in larger cables, while sheath currents are also unevenly distributed. The present study employs 2-D Finite Element (FE) models to evaluate how accurate the Standard method for calculating the λ_1 factor is in cables with non-magnetic armor. Their validity is further enhanced by means of Filament Method. IEC 60287 appears to overestimate the temperature, particularly for larger conductor sizes, by up to 7°C (8%). Finally, suitable Reductive Factors are suggested which could improve the accuracy of the IEC method.

Index Terms-- Current rating, Numerical modeling, Power transmission, Submarine cables, Induced losses, Proximity effect

I. INTRODUCTION

THE cost of a cable circuit is partly determined by the L conductor size, and is often crucial for the viability of projects such as Offshore Wind Farms (OWFs). To optimize the cable size, an accurate calculation of losses is required. In HVAC cables, the currents induced in metallic sheaths yield extra heat losses, thus further contributing to the temperature rise of the conductor. These induced losses are currently treated by IEC 60287-1-1 by means of the factor λ_1 [1]. The existing method does not consider proximity effects when calculating λ_1 , meaning that the accuracy may be reduced for individually sheathed cables in close physical proximity. The distribution of current density J in the conductors will affect sheath losses. Fig. 1 shows the ohmic losses in the sheaths when non-uniform *J* in 1000 mm² conductors is considered. If uniform J was considered, ohmic losses would be 20% higher and the maximum loss density would be equal to 7105.8 W/m³.

This paper studies the influence of proximity effects on sheath losses when Single-Core (1C) cables are laid in trefoil, and for three-core (3C) submarine cables without magnetic armor. Losses are studied by means of 2-D Finite Element Method (FEM), which is considered a black-box approach, and Filament Method (FM), which is a more readily understandable one. The former is used as a reference in order to review the existing analytical equations. Reductive Factors (RFs) are proposed, which could improve the accuracy of the IEC calculations, based on the parametric analysis done.

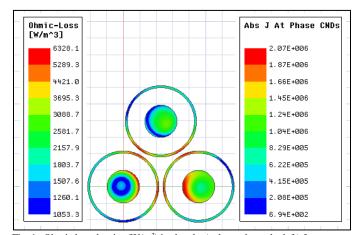


Fig. 1. Ohmic loss density (W/m^3) in sheaths (color code on the left) for uneven $J(A/m^2)$ in conductors (color code on the right) at phase angle 0° .

II. "TYPES" OF INDUCED LOSSES IN SHEATHS

Losses induced in sheaths can be divided into two groups, depending on the type of bonding: losses mainly due to circulating currents flowing in sheaths if they are Solidly Bonded (SB), and those caused by eddy currents circulating radially and azimuthally for Single-Point Bonded (SPB) sheaths. As Anders points out [2], eddy current loss occurs irrespective of the bonding method, although it is often ignored in solidly bonded sheaths where it is assumed small in magnitude compared to circulating current loss. This section reviews the Standard formulae and their origins.

A. Eddy Current Loss

Sheath eddy currents of 1st order occur as a result of the combined effect of the internal conductor current and the external currents in neighboring cables. Eddies local to the sheath wall only (self-induced currents) are generated by the

This work was supported by Cablel® Hellenic Cables S.A., Viohalko Group (http://www.cablel.com/).

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All data supporting this study are openly available from the University of Southampton repository at: http://dx.doi.org/10.5258/SOTON/D0780

former, while currents circulating from wall to wall of the same sheath occur by the latter. Self-induced currents are in practice negligible. A 2nd order eddy current arises from the effect of the magnetic field of 1st order eddies in neighboring sheaths and the process continues until the successive order eddies have negligible effect [3] in the sheath considered.

1) Jackson's Method:

The most precise analytical approach was provided by Jackson in 1975 [3]. He successfully extended Carter's earlier work [4] accounting for higher order eddy currents by means of formulae including infinite series. The 1st order loss factor in terms of external currents is shown in (1) assuming 1C cables in trefoil spaced formation with three-phase balanced currents.

$$\lambda_{1\,1st}^{"} = \frac{R_S}{R} \sum_{n=1}^{\infty} \left[2\left(\frac{d}{2s}\right)^{2n} \frac{m^2}{n^2 + m^2} \left(2 - \cos\frac{n\pi}{3}\right) \right] \tag{1}$$

where R_S is the resistance of sheath per unit length (pul) of cable (Ω/m) , R is the ac resistance of conductor pul (Ω/m) , d is the mean diameter of sheath (mm), s is the distance between conductor axes (mm) and m is the frequency to resistance dimensionless ratio given by (2):

$$m = \frac{\omega}{R_S} \cdot 10^{-7} \tag{2}$$

where ω is the angular frequency (rad·s⁻¹). Although (1) appears to be accurate enough for widely spaced cables and small m values, i.e. less conductive sheaths (e.g. Lead), considerable errors of up to 20% may occur for cables in close formation, or those with more conductive sheaths (e.g. Aluminium) if higher order eddy currents are excluded [3]. $2^{\rm nd}$ or higher order eddy current loss factors consist of multiple infinite series, and as shown by Jackson [3], the effect of $4^{\rm th}$ and higher order currents can usually be neglected.

2) *IEC* 60287-1-1 – *ERA Method*:

The report published by ERA [5] suggests an empirical method based on the previous work published by Heyda [6], which comprises tabulated values. As reported in [5], these are in an excellent agreement with Jackson's method. Although Jackson's work is recognized as valuable and very accurate, the computation of infinite series was a laborious task in 1979. Hence, a simpler method suitable for hand calculation is proposed by [5]. ERA's method has been adopted by IEC 60287 and is currently used to calculate eddy current losses in single-point bonded sheaths. The relevant formulae are presented in the following equations for 1C cables in triangular formation:

$$\lambda_{1,\text{IEC}}^{"} = \frac{R_{S}}{R} \left[g_{S} \lambda_{0} (1 + \Delta_{1} + \Delta_{2}) + \frac{(\beta_{1} t_{S})^{4}}{12 \cdot 10^{12}} \right]$$
(3)

where $t_{\rm S}$ is the thickness of sheath (mm) and

$$g_{\rm S} = 1 + \left(\frac{t_{\rm S}}{D_{\rm S}}\right)^{1.74} (\beta_1 D_{\rm S} \cdot 10^{-3} - 1.6)$$
 (4)

$$\lambda_0 = 3 \left(\frac{m^2}{1 + m^2} \right) \left(\frac{d}{2s} \right)^2 \tag{5}$$

$$\Delta_1 = (1.14m^{2.45} + 0.33) \left(\frac{d}{2s}\right)^{0.92m + 1.66} \tag{6}$$

$$\beta_1 = \sqrt{\frac{4\pi\omega}{10^7 \rho_{\rm S}}} \tag{7}$$

where D_S is the external diameter of cable sheath (mm), ρ_S is the electrical resistivity of sheath material ($\Omega \cdot$ m) and $\Delta_2 = 0$ for 1C cables in trefoil formation. It is readily noticeable that the sum factor in (1) leads to (5) for n = 1. Term Δ_1 is expected to approximate the infinite series derived by Jackson's paper [3].

The assumption that the conductor current is concentrated along the longitudinal axis of the sheath is implied in both (1) and (3). Although expected to be representative enough for small or spaced conductors, it may not hold for larger conductors in trefoil. The external magnetic field produced by the three conductor currents is actually reduced by the crowding of the currents towards each other, as Arnold notes [7]; hence, (1) and (3) may become conservative for larger conductor sizes, as the present paper demonstrates. Heyda considers the likely impact of the proximity effects in [6] but assumes them to be insignificant, owing to the possible use of Milliken conductors for higher power demands. Presently, Milliken conductors are rarely used for 3C subsea cables due to the practical difficulties in providing sufficient water blocking capability and the increase in cable size that complicates the installation stage.

B. Circulating Current and Total Losses - IEC 60287-1-1

When sheaths are solidly bonded, induced currents flow in one direction along one sheath, returning along another one. The formulae adopted by IEC 60287 date back to the work published by Arnold [8] and are presented in this section for three 1C cables in trefoil formation.

$$\lambda'_{1,\text{IEC}} = \frac{R_{\text{S}}}{R} \frac{1}{1 + \left(\frac{R_{\text{S}}}{X}\right)^2} \tag{8}$$

where X is the reactance pul of sheath (Ω/m) , i.e.

$$X = 2\omega 10^{-7} \ln\left(\frac{2s}{d}\right) \tag{9}$$

Total losses in the sheath consist of losses caused by circulating and eddy currents and the respective factor is shown in (10) [1].

$$\lambda_{1,\text{IEC}} = \lambda'_{1,\text{IEC}} + \lambda''_{1,\text{IEC}} \tag{10}$$

Although eddy current loss is important for single-point bonded sheaths, it becomes less significant when solidly bonded sheaths are considered, as already cited by Anders [2]. IEC 60287-1-1 has adopted this view, by neglecting $\lambda_{1,\text{IEC}}$ " for solid bonding cases. However, $\lambda_{1,\text{IEC}}$ " may become significant for cables laid in close proximity, whereas $\lambda_{1,\text{IEC}}$ is minimized for touching formation. Assuming three cables of outer diameter $d_{\rm e}$ with a Cu conductor of radius equal to 20 mm and an Al sheath of $t_{\rm S}=1$ mm, $\lambda_{1,\text{IEC}}$ " rises from about 0.04 to 0.3 when reducing from $s=3d_{\rm e}$ to $s=d_{\rm e}$ (touching) and at the same moment $\lambda_{1,\text{IEC}}$ " = 0.8 for $s=d_{\rm e}$. Therefore, $\lambda_{1,\text{IEC}}$ " and $\lambda_{1,\text{IEC}}$ " may not be so incomparable and the omission of eddy current loss appears to be questionable for cables in touching arrangement.

Furthermore, (8) accounts only for the sheath dc resistance, implying uniformly distributed sheath current I_S . However, Arnold cites in [8] that uneven distribution of I_S is expected in sheaths of neighboring cables. The closer the cables are laid to one another, the greater the variation in the induced emf along the sheath circumference and the more uneven the distribution of I_S will be. More recently, Kovač [9] has taken this into account via FM when calculating sheath losses for solidly bonded cables laid in touching, flat formation. However, he neglected the uneven current distribution in conductors, assuming they could be sufficiently represented by a single filament. It is shown in the present paper that for large conductor sizes, where the proximity effect within the conductor is not negligible, this assumption does not hold true. Similar conclusions are made by Ferkal [10], who implemented an analytical approach: discrepancies up to 16% against methods neglecting the effect of the conductor when evaluating the screen losses are reported for a conductor of radius 22.56 mm.

III. FILAMENT METHOD (FM)

A. Method Description

FM relies on physically representing the metallic parts of a 3C cable by means of a number of thinner cylindrical wires (or filaments), each one carrying a uniform current density (no skin and proximity effects). The current in each filament is not known in advance; however, the total sum of filament currents must be equal to the total conductor or sheath current. The interaction between filaments is represented by their self and mutual inductances. One of the earliest works is published by Comellini [11], who considers also the effect of soil impedance. Kovač [12] employs a similar formulation and he additionally demonstrates that modeling of the ground return path is not necessary when dealing with loss calculations. Hence, a formulation similar to that of Moutassem [13] is derived, which is also referred to [2]. This latter version is employed in the present paper. Only the final equation is shown in (11) to save space; **I** is the vector of n filament currents (A), \mathbf{R}_d is a diagonal $n \times n$ matrix representing R_i , namely the dc resistance of filament "i" (Ω /m), **G** is the inductance matrix of size $n \times n$ with elements equal to $ln(1/s_{ij})$, where s_{ij} is the distance between filaments "i" and "j" (m), M is the connection matrix ($m \times n$),

where m is the number of conductors and sheaths in total (they are in general called *composites*) and I^c is the vector of m composite currents (A). I^c is known in advance, because composite conductor currents are given, while composite sheath currents may be zero and non-zero for single-point and solid bonding cases, respectively. In the latter case sheath currents have to be calculated as described by Anders [2] in \$8.5/(8.133). The remaining quantities are all known except for I, which is the unknown vector to be solved for. The reader is referred to [13] and [2] to obtain the full description of the method.

B. Comparison VS 2-D FE models

FE models have been employed since the late 1980s for the calculation of induced losses in cables, such as [14]. They are also used as benchmarking tools for simpler, analytical models, such as [13] and [15]. In this section, the use of (11) is verified against FE models; results are shown in Table I for copper conductor, lead sheathed cables, laid in trefoil, close formation, with conductor radius $r_{\rm C}$, sheath inner radius $r_{\rm S,in}$ and thickness $t_{\rm S}$. Tests for both λ_1 " and λ_1 cases are presented. As shown in the 3rd and 4th columns of Table I, the % relative difference between FE and FM models, i.e. $e_{\rm FE,FM}$, is kept fairly low for $660 \le n \le 760$. Better accuracy is obtained, as expected, for $2560 \le n \le 2950$, as shown in the 6th and 7th columns of Table I.

TABLE I
FM VS FE MODELS FOR VARIOUS CABLE SIZES AND NUMBER OF FILAMENTS

$r_{\rm C}/r_{ m S,in}/t_{ m S}$ [mm]	n	$e_{ ext{FE,FM}}, \ \lambda_1$ " [%]	$e_{ ext{FE,FM}}, \ \lambda_1 [\%]$	n	$e_{ ext{FE,FM}}, \ \lambda_1$ ", [%]	$e_{ ext{FE,FM}}, \ \lambda_1 \ [\%]$
10 / 20 / 1.0	663	0.03	0.19	2565	0.02	0.06
20 / 35 / 1.5	726	1.62	1.75	2817	0.54	0.59
30 / 50 / 2.0	759	4.19	4.25	2943	1.21	1.23

IV. FINITE ELEMENT ANALYSIS (FEA) VS EXISTING ANALYTICAL METHODS

FM is a useful approach, demonstrating physically the way proximity effects affect losses in 3C cables. It may also be quicker, in terms of the total set up and solution time, than FE method (FEM), without significant compromise in accuracy. FEM and FM are not limited to balanced loading conditions and are capable of treating unbalanced currents. They are not easily usable for hand calculations. Balanced conditions are typically assumed when calculating cable losses.

A 2-D FE solver is utilised in this section, firstly to review the accuracy of the existing analytical methods. Results from FM models, which have been derived based on (11), are also presented for completeness. As expected, they are in close agreement with FEA. Focus is made on 3C lead sheathed cable cores, which is the case in terms of the sheaths of OWF export cables. Two different assumptions are made with regard to the current density J in phase conductors: uniform (no skin/proximity effects) and non-uniform (skin/proximity effects considered), namely $J_{\rm u}$ and $J_{\rm nu}$, respectively. Solid conductors are taken into account for simplicity, but the effect of stranded

$$\mathbf{I} = \left[\mathbf{R}_d + j \frac{\omega \mu_0}{2\pi} \mathbf{G} \right]^{-1} \times \mathbf{M}^T \left[\mathbf{M} \left[\mathbf{R}_d + j \frac{\omega \mu_0}{2\pi} \mathbf{G} \right]^{-1} \mathbf{M}^T \right]^{-1} \mathbf{I}^{\mathbf{c}}$$
(11)

conductors, mostly used in practice, is studied in Section IV-C1). Several geometrical parameters are considered to vary within representative ranges: conductor radius $r_{\rm C}$ from 10 to 30 mm, sheath inner radius $r_{\rm S,in}$ from 15 to 60 mm and sheath thickness $t_{\rm S}$ from 1.0 to 4.0 mm. To check individually for the influence of the variation of each parameter, the rest remain unchanged and equal to a moderate value each time.

Empirical, RFs are then presented, based on the parametric analysis done. These could be combined with the formulae of the current IEC version in order for its accuracy to be improved.

A. Single-Point Bonding (SPB) Loss

This section presents the results derived from four different methods, i.e. those suggested by Jackson and IEC, as well as FEA and FM. The effect of eddy currents up to 3rd order is taken into consideration with respect to Jackson's method [3].

1) Lead Sheaths:

Lead sheaths are routinely used for subsea, export cables where the water-tightness of insulation is of crucial importance. Fig. 2 illustrates the effect of varying $r_{\rm C}$ on λ_1 " as calculated by four different methods. Since it is common to think of conductor cross-sectional areas (XSAs), the values $r_C = 10$, 20 and 30 mm correspond, approximately, to 300, 1000 and 2500 mm². The results derived by the methods of IEC 60287 and Jackson [3] are in good agreement. This can be readily justified by the fact that the former, which is based on ERA's publication [5], successfully replaces the infinite series suggested by Jackson by means of the Δ_1 factor shown in (6). Similar agreement occurs when FEA is applied considering $J_{\rm u}$ in phase conductors. However, once J_{nu} is considered, significant discrepancies appear. It is noticeable in Fig. 2 that for decreasing $r_{\rm C}$, $J_{\rm nu}$ values tend closer to $J_{\rm u}$ ones, with the relative difference shrinking from 60% to 1%.

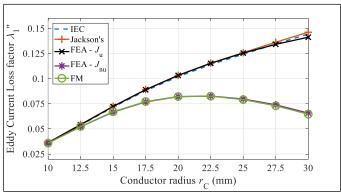


Fig. 2. Dependence of λ_1 " on r_C , $r_{S,in} = 40$ mm, $t_S = 2.5$ mm – Lead Sheaths.

For increasing $r_{S,in}$ a similar trend is obtained; assuming a conductor with $r_C = 20$ mm the difference drops from 43% down to 9%. The more remote the sheath is from the non-uniform current source, the less it is affected by it. In other words, impact of the non-uniform conductor current is more significant with a thinner insulation. The effect of varying t_S on the divergence between J_u and J_{nu} results is even weaker compared to r_C and $r_{S,in}$.

2) Variation VS Sheath Resistivity, ρ_S :

Materials besides lead are seldom used for submarine cable sheaths. However, it is worth noting the relative difference between J_{nu} results and the existing analytical methods when varying ρ_{S} . As shown in Fig. 3, this is kept nearly constant, about 28%, for ρ_{S} values in between Al and lead materials [1] when a conductor of r_{C} = 22.5 mm (or 1400 mm²) is considered.

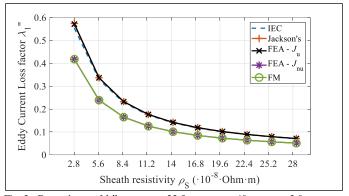


Fig. 3. Dependence of λ_1 " on ρ_S , $r_C = 22.5$ mm, $r_{S,in} = 40$ mm, $t_S = 2.0$ mm.

3) Effect of the Proximity Effect in Conductors:

Smaller conductors will see less intense skin and proximity effects, and hence a more uniform distribution of current. Although the skin effect can be strong in large conductors, the non-uniform current remains fairly symmetrical for widely spaced conductors. However, proximity effect is expected to further distort the current distribution, affecting the magnetic flux induced and hence the induced losses. This is neglected in the existing standards. To demonstrate the significance, the current distribution for 3 x 1000 mm² conductors is illustrated in Fig. 4. In particular, the phase average (average for a full cycle of 0.02 s, so from phase 0° to phase 360°) of current density $J_{\rm C}$ along $d_{\rm C}$ is shown. The spatial average of $J_{\rm C}$ is shifted about 40% from the center ($d_{\rm C}=20$ mm) of the conductor and is closer to the neighboring one on the right, thus confirming the non-symmetry of current distribution.

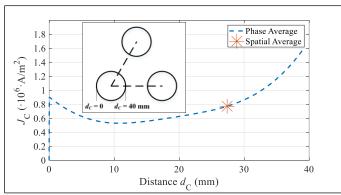


Fig. 4. Current density along $d_{\rm C}$ for 3 x 1000 $\overline{\rm mm^2}$ conductors.

Induced losses in sheaths depend on the magnetic flux along their circumference. Fig. 5 shows magnetic flux levels at phase angle 0° along L when two extreme conductor sizes (150 mm² and 2000 mm²) are considered, both with $J_{\rm nu}$. The maximum difference reaches 0.79 mT and the average is 0.38 mT, for

matching current input I, axial separation s and sheath geometry. The influence of proximity effects in conductors on eddy current loss is considered by neither Jackson [3] nor Parr [5]. As implied in the former's formulation, linear currents are assumed as the field sources. This appears to be a quite reasonable assumption for lower conductor sizes, but not so when higher sizes are considered, as illustrated in Fig. 5.

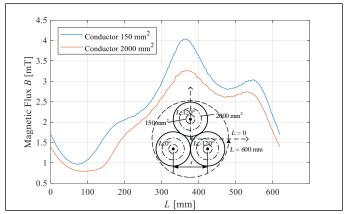


Fig. 5. Distribution of magnetic flux along the circumference above the 3 cores for 150 mm² and 2000 mm² conductors.

4) Approximating Formulae Suggested:

As shown in Section IV-A1), $r_{\rm C}$ and $r_{\rm S,in}$ appear to be the geometrical parameters mainly affecting the divergence between analytical and FE methods. RFs for single-point bonding losses are found, by minimizing the square difference of λ_1 " obtained with FEA and the corrected IEC method. The new value of λ_1 " is shown in (12).

$$\lambda_{1,\text{New}}^{\prime\prime} = RF_{\text{SPB}} \cdot \lambda_{1,\text{IEC}}^{\prime\prime}$$
 (12)

where $RF_{\rm SPB} = \lambda_{\rm 1,New}$ "/ $\lambda_{\rm 1,IEC}$ " is the Reductive Factor (RF) for single-point bonding case. Since $\lambda_{\rm 1,New}$ " should be in close agreement with $\lambda_{\rm 1,FEA}$ " (ideally $\lambda_{\rm 1,New}$ " = $\lambda_{\rm 1,FEA}$ "), the ratio $\lambda_{\rm 1,FEA}$ "/ $\lambda_{\rm 1,IEC}$ " is illustrated in Fig. 6, where $X_{\rm sc} = r_{\rm S,in} - r_{\rm C}$. The shapes of the curves suggest that the ratio could be approximated by polynomial functions of $r_{\rm C}$ and $X_{\rm sc}$.

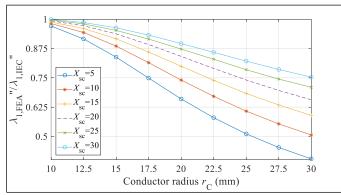


Fig. 6. Comparison of FEA and IEC results.

Results of both linear and polynomial of 3rd order are shown in Table II, for certain indicative cable sizes. Better accuracy is obtained when the latter fitting is chosen, while sufficiently

good correction is achieved with the former one, especially for larger cable sizes. *R*-square is also included for informative purposes.

TABLE II RELATIVE DIFFERENCE OF THE CORRECTED IEC, SPB LOSS FACTOR VS FEA

$r_{\rm C}/r_{\rm S,in}/t_{\rm S}$	$rac{\lambda_{1, ext{New}}^{\prime\prime}-\lambda_{1, ext{FEA}}^{\prime\prime}}{\lambda_{1, ext{FEA}}^{\prime\prime}}\cdot 100\%$			
[mm]	Linear (R-square: 0.9239)	3 rd polynomial (<i>R</i> -square: 0.9985)		
10.0/ 20.0/ 1.0	-6.0%	-0.5%		
20.0/ 35.0/ 1.5	-3.3%	-0.5%		
30.0/ 50.0/ 2.0	-4.6%	-0.5%		

The exact form of the RF formula derived is shown in (14) and (15) (see Appendix) for 3^{rd} order polynomial and linear approximation, respectively. Since r_C and $r_{S,in}$ appear to mainly affect the divergence between IEC and FEA results, other parameters, e.g. conductor resistivity, ρ_C , and t_S , are assumed to have a constant, moderate value in the parametric analysis done. The applicability of (14) and (15) for different ρ_C and t_S values is considered in section IV-C2).

B. Solid Bonding (SB) Losses

This section presents results for solidly bonded sheaths, i.e. λ_1 ' plus λ_1 '', derived from IEC, FEA and FM calculations. Both FE and FM models do not distinguish circulating and eddy losses, whereas IEC considers them separately, as shown in (10). Results are presented for lead sheaths, while the effect of sheath conductivity is also studied.

1)Lead Sheaths:

The trends seen for lead sheaths resemble qualitatively those seen for single-point bonding loss regarding $r_{\rm C}$, $r_{\rm S,in}$ and $t_{\rm S}$ parameters. $r_{\rm C}$ appears to be the geometric parameter mainly affecting loss results: a maximum difference of 52% between FEA $-J_{\rm nu}$ and IEC values is shown in Fig. 7. Increase in $r_{\rm S,in}$ leads to a slight decrease of the divergence from 25% to 10%, while impacts from $t_{\rm S}$ are again less significant.

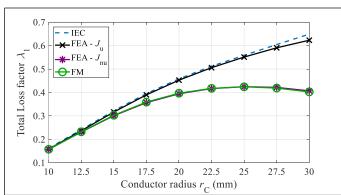


Fig. 7. Dependence of λ_1 on r_C , $r_{S,in} = 40$ mm, $t_S = 2.5$ mm – Lead Sheaths

2) Variation VS Sheath Resistivity, ρ_S :

Although the influence of variation in ρ_s does not derive surprising results for λ_1 ", as shown in Fig. 3, more interesting is the dependence of λ_1 against ρ_s , as shown in Fig. 8. For higher ρ_s values, the agreement between FEA – J_u values and IEC

appears good enough. However, it becomes worse for lower ρ_s , implying that the proximity effect in conductors is not the only factor at play. This is further discussed in the next subsection.

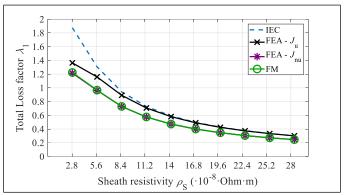


Fig. 8. Dependence of λ_1 on ρ_S , $r_C = 22.5$ mm, $r_{S,in} = 40$ mm, $t_S = 2.0$ mm.

3) *Interpretation of Results – Effect of Cable Spacing:*

Besides the influence the proximity effect in conductors has on solid bonding losses, skin and proximity effects in sheaths themselves are modeled in FEA. Skin effect is fairly weak for the sheaths: calculated skin depths are about 33 mm (lead) and 12 mm (Al), much larger than the range of $t_{\rm S}$ values involved. Two identical 3C cable geometries are examined to further investigate the effect of distance s, on sheath resistance and circulating current, $I_{\rm S}$. Lead and Al sheaths of equal geometry are assumed to derive comparable results, while both $J_{\rm u}$ and $J_{\rm nu}$ are considered. Medium values for $r_{\rm C}$ and $r_{\rm S,in}$ are also assumed (20 mm and 35 mm, respectively). Sheath resistance and current are extracted by FEA. Their ratios to the corresponding IEC values, namely $R_{\rm FEA}/R_{\rm IEC}$ and $I_{\rm FEA}/I_{\rm IEC}$, respectively, are considered and shown in Table III and Table IV.

TABLE III EFFECT OF CABLE SPACING ON SHEATH RESISTANCE AND I_{S} – LEAD SHEATH

ĿГ	EFFECT OF CABLE SPACING ON SHEATH RESISTANCE AND I_S – LEAD SHEATH							
	Cable Spacing s	$R_{\text{FEA}}/R_{\text{IEC}}$ $-J_{\text{u}}$	$I_{ m FEA}/I_{ m IEC} - J_{ m u}$	$R_{\rm FEA}/R_{\rm IEC} - J_{ m nu}$	$I_{ m FEA}/I_{ m IEC} \ -J_{ m nu}$			
	d_{core} (touching formation)	1.32	0.87	1.28	0.80			
	$1.5 \times d_{\rm core}$	1.06	0.97	1.04	0.95			
	$3 \times d_{\text{core}}$	1.01	1.00	1.00	0.99			

TABLE IV

Ε	EFFECT OF CABLE SPACING ON SHEATH RESISTANCE AND $I_{\rm S}-{\rm AL}$ SHEATHS								
	Cable Spacing s	$R_{\text{FEA}}/R_{\text{IEC}}$ $-J_{\text{u}}$	$I_{ m FEA}/I_{ m IEC} - J_{ m u}$	$R_{\text{FEA}}/R_{\text{IEC}}$ $-J_{\text{nu}}$	$I_{ m FEA}/{ m I}_{ m IEC} - \ J_{ m nu}$				
	d_{core} (touching formation)	1.31	0.78	1.27	0.73				
	1.5 x d _{core}	1.05	0.93	1.04	0.92				
	$3 \times d_{\text{core}}$	1.01	0.99	1.00	0.99				

As shown, by reducing s, $R_{\rm FEA}/R_{\rm IEC}$ increases and $I_{\rm FEA}/I_{\rm IEC}$ decreases. IEC results are in a good agreement with FE ones for spaced cables, whereas the situation appears different for cores being in close proximity one another; the increase in $R_{\rm FEA}/R_{\rm IEC}$ implies that $I_{\rm S}$ is not uniformly distributed along sheath.

For Lead sheaths, FEA and IEC sheath losses appear alike each other when J_u is considered. The reduction of current ratio

is compensated by the respective increase in resistance ratio, thus leading to nearly equal losses. Lower $I_{\rm S}$ values are recorded once $J_{\rm nu}$ is considered, because of the lower magnetic field actually induced. Although higher $R_{\rm S}$ values are also seen in this case, the current dominates in the loss calculation ($W_{\rm S} = I_{\rm S}^2 R_{\rm S}$), thus leading to lower losses.

J in conductors seems to affect the current ratio in terms of Al sheaths, leading to lower losses. However, the current ratio is significantly lower for $J_{\rm u}$ assumption and the increase in resistance ratio is not capable of compensating the respective decrease in the current ratio. Due to the higher conductivity of Al, higher eddy currents occur, which cancel out locally the overall circulating current ($I_{\rm S}$) to a greater extent, thus yielding a less uniform J along sheaths' circumference and a stronger proximity effect.

4) Approximating Formulae Suggested:

Similar analysis to subsection IV-A4) is undertaken for solid bonding losses, with the same geometrical parameters being varied to obtain RFs. The new value of λ_1 is shown in (13). Results of both linear and polynomial of 3rd order are shown in Table V, for certain indicative cable sizes. Better accuracy is obtained when the latter fitting is chosen, while sufficiently good correction is achieved with the former one. The relevant formulae for 3rd order polynomial and linear are shown in (14) and (15), respectively, in Appendix. Similar checks to those of section IV-A4) are done and presented in section IV-C2).

$$\lambda_{1,\text{New}} = RF_{\text{SB}} \cdot \lambda_{1,\text{IEC}} \tag{13}$$

TABLE V
RELATIVE DIFFERENCE OF THE CORRECTED IEC, SB FACTOR VS FEA

RELATIVE DITTERENCE OF THE CORRECTED IEC, SDITACTOR VOTER						
$r_{\rm C}/r_{\rm S,in}/t_{\rm S}$	$\frac{\lambda_{1,\text{New}} - \lambda}{\lambda_{1,\text{FEA}}}$	1,FEA · 100%				
[mm]	Linear (R-square: 0.9237)	3 rd polynomial (<i>R</i> -square: 0.9991)				
10.0/ 20.0/ 1.0	-3.3%	-0.5%				
20.0/ 35.0/ 1.5	-1.9%	0.4%				
30.0/ 50.0/ 2.0	-2.1%	0.1%				

C. Review of the Assumptions Made

1)Effect of Conductor Structure:

Solid conductors, which are assumed in the present paper, are less often used in practice, mainly due to mechanical reasons. Stranded conductors usually have uneven dc resistance throughout their cross-section, because of the different lay length applied between the various layers of strands during the twisting process. Therefore, proximity effect is expected to be slightly weaker compared with solid conductors.

The lay length of outer layers depends on the production process of each manufacturer. The assumption of 10% longer outer strands is made in this section. In addition, to avoid simulating the conductor strand by strand, the electrical conductivity of the conductor is varied as a linear function of radius. Considering $r_{\rm C}=20$ mm and $t_{\rm S}=2.5$ mm, eddy current loss appears 1% higher once variable conductivity is assumed, while at the same moment it is 26% higher when $J_{\rm u}$ is assumed. Therefore, the assumption of solid conductors appears to be

adequately reasonable in terms of its effect on sheath loss. It is noted that overlength values higher than 1.1 are not often met in practice.

2) Effect of t_S , t_J and ρ_C :

Certain assumptions are made for the derivation of both RF_{SPB} and RF_{SB} for the sake of simplicity. In particular, a constant, moderate value is considered for t_S , while the jacket over the sheath is supposed to be of thickness $t_J = t_S$. Hence, the applicability of (14), (15) must be checked for variable t_S , t_J , within reasonable margins. r_C , X_{SC} are varied for each pair of t_S , t_J values and the average of the relative difference ($\lambda_{1,New}$ - $\lambda_{1,FEA}$) / $\lambda_{1,FEA}$, namely e_{avg} , is recorded in this section. Results are shown in Table VI and Table VII. e_{avg} in terms of RF_{SPB} – FEA appears to be consistent enough and not much affected by t_J , t_S . That for RF_{SB} – FEA increases for higher t_S , t_J , while at the same time e_{avg} for IEC – FEA decreases. Although the RFs appear to work less effectively for some extreme cases, cables with such thick sheaths and even thicker jackets are not possible in practice.

TABLE VI AVERAGE RELATIVE DIFFERENCE FOR VARIOUS GEOMETRIES – SPB LOSS

TVERRIGE REEMTIVE DITTERENCE FOR VARIOUS GEOMETRIES STD EOSS								
	$e_{ m avg}$	[%], $t_J = 2$	$\mathbf{x} t_{\mathrm{S}}$	$e_{\text{avg}} [\%], \ t_{\text{J}} = 3 \text{ x } t_{\text{S}}$				
t [mm]	IEC -	(15) –	(14) –	IEC –	(15) –	(14) –		
t _S [mm]	FEA	FEA	FEA	FEA	FEA	FEA		
1.0	36.4	4.2	1.4	36.6	4.6	2.1		
2.0	36.8	4.1	1.7	37.6	4.2	2.3		
3.0	36.7	4.0	1.7	37.7	4.1	2.4		
4.0	36.3	3.8	1.6	37.3	4.0	2.2		

TABLE VII
AVERAGE RELATIVE DIFFERENCE FOR VARIOUS GEOMETRIES – SB LOSS

	e_{avg} [%], $t_{\text{J}} = 2 \times t_{\text{S}}$			$e_{ m avg}$	$[\%], t_{\rm J} = 3$	$x t_S$
$t_{ m S}$	IEC -	(15) –	(14) –	IEC -	(15) –	(14) –
[mm]	FEA	FEA	FEA	FEA	FEA	FEA
1.0	21.1	3.1	1.5	19.6	2.9	0.9
2.0	18.2	2.7	1.2	15.9	3.7	3.0
3.0	16.2	3.6	2.7	13.3	5.7	4.8
4.0	14.6	5.0	4.1	11.4	7.2	6.3

Besides the effect of $t_{\rm S}$, $t_{\rm J}$, that of conductor resistivity, $\rho_{\rm C}$, is checked. $\rho_{\rm C}$ is selected equal to the average value between that of Cu conductors at 20°C, $\rho_{\rm Cu_20^\circ}$, and Al at 90°C, $\rho_{\rm Al_90^\circ}$, [1] during the derivation of the RFs. However, the higher $\rho_{\rm C}$, the stronger the proximity effect of the conductor and vice versa; thus, this assumption is also worth reviewing. Results are shown in Table VIII. Values for the mean of $\rho_{\rm Cu_20^\circ}$ and $\rho_{\rm Al_90^\circ}$ are also given as a reference. RFs give better results when tested for $\rho_{\rm Cu_20^\circ}$, since the proximity effect is more intense and $e_{\rm avg}$ between IEC – FEA is higher. On the contrary, they give relatively worse results for $\rho_{\rm Al_90^\circ}$, since the proximity effect is less intense and $e_{\rm avg}$ between IEC – FEA is lower. In any case, RFs provide results closer to FEA.

V. EFFECT ON THERMAL RATING

The results shown in the present study suggest lower induced losses compared to the formulae provided by IEC 60287 for lead sheathed cable cores laid in close trefoil arrangement. The thermal impact of this reduction is assessed in the present

section, considering three 1C Lead sheathed cores in "typical" subsea installation conditions and solidly bonded sheaths.

TABLE VIII

AVERAGE RELATIVE DIFFERENCE FOR VARIOUS CONDUCTOR RESISTIVITIES							
	e _{avg} [%], SPB Loss			e_{avg} [%], SB L	osses	
$ ho_{\mathrm{C}}$	IEC – FEA	(15) – FEA	(14) – FEA	IEC – FEA	(15) – FEA	(14) – FEA	
$\frac{\rho_{\text{Cu}_20^{\circ}\text{C}} + \rho_{\text{Al}_90^{\circ}\text{C}}}{2}$	33.2	5.3	0.7	19.4	3	0.3	
$ ho_{\mathrm{Cu}_20^{\mathrm{o}}}$	42.0	7.6	5.6	23.1	3.8	3.0	
Q A1 90°	22.1	8.0	7.0	14.5	4.6	3.6	

Several researchers have already dealt with FE modeling of 3C cables with magnetic wire armor, such as Goddard [15], Bremnes [16] and da Silva [17]. They all agree to the point that circulating currents are not expected in armor wires. The approach of series connection between all armor wires used by [16] and [17] is applied here to ensure no circulating currents in the non-magnetic armor. Three indicative cable sizes as shown in Table IX are simulated with and without non-magnetic armoring above the 3 cores. The changes in sheath losses are lower than 0.5%, thus implying that the presence of nonmagnetic armor has almost no effect on induced losses in sheaths. Similar results about the difference in λ_1 are presented by Benato in [18], based on the 3-D analysis performed for 3C cables with stainless steel and without armor. Consequently, the non-magnetic armor may be neglected for simplicity when sheath loss is of interest.

For each cable size considered, sheath losses calculated by IEC 60287 and FE models are used, while conductor loss from FEA is imported in both cases. The cable is considered buried 1 m deep in soil of thermal resistivity 0.7 KmW⁻¹ at 15°C ambient temperature under steady-state conditions. Eddy current loss (λ_1 ") is accounted for by the FE models, whereas two cases are considered for IEC calculations; those ignoring and including λ_1 ", respectively. The corresponding results are illustrated in Table IX.

TABLE IX
MAXIMUM CONDUCTOR TEMPERATURE: SHEATH LOSSES CALCULATED BY
FEA AND IEC FOR NON-MAGNETIC ARMOURED 3C CABLES

$r_{\rm C}/r_{ m S,in}/t_{ m S}$ [mm]	FE models [°C]	$IEC/$ $\lambda_1^{"} = 0$ $[^{\circ}C]$	Δθ ₁ [°C]	IEC/ λ_1 " $\neq 0$ [°C]	$\Delta heta_2$ [°C]
10.0/ 20.0/ 1.5	90.0	89.7	0.3	90.4	-0.4
20.0/ 35.0/ 2.5	90.0	91.4	-1.4	96.5	-6.5
30.0/ 50.0/ 3.5	90.0	97.2	-7.2	109.2	-19.2

As shown in Table IX, $\Delta\theta_1$, which occurs from the subtraction between 2^{nd} and 3^{rd} columns of Table IX, is low for small and medium cable sizes. However, FE results are about 7° C (or 8%) lower for larger cable sizes due to the IEC overestimating the losses. The FEA includes fully the eddy currents and resulting proximity effects, the extent of which is outweighed by the reduction in circulating current loss. As seen by $\Delta\theta_2$ values, which occur from the subtraction between 2^{nd} and 5^{th} columns, IEC can become overly conservative if including λ_1 ", particularly for larger cable sizes.

(15)

$$RF_{3}rd(r_{C}, X_{sc}) = p_{00} + p_{10}X_{sc} + p_{01}r_{C} + p_{20}X_{sc}^{2} + p_{11}X_{sc}r_{C} + p_{02}r_{C}^{2} + p_{30}X_{sc}^{3} + p_{21}X_{sc}^{2}r_{C} + p_{12}X_{sc}r_{C}^{2} + p_{03}r_{C}^{3}$$
(14)

A threshold above which the RFs are significant may be identified from the present analysis; based on Fig. 7, total solid bonding losses appear to be about 14% lower than IEC predicts for a conductor size of $r_{\rm C}=20$ mm or, approximately, 1000 mm². The temperature difference for this case starts to become significant (above 1°C), as shown by $\Delta\theta_1$ and $\Delta\theta_2$ values of Table IX. Although the value $r_{\rm C}=30$ mm or, approximately, 2500 mm² corresponds to the higher standardized conductor size [19], this is still used in practice. Milliken conductors are not easily manageable for large subsea projects, mainly because of the increased cable weight and the difficulty in making them watertight enough.

VI. CONCLUSION

The work presented in this paper reviews the formulae for induced losses in sheaths used by IEC 60287 for cables in trefoil touching formation, making focus on three-core (3C) submarine cables with non-magnetic armor. The present Standard method implies uniform currents in the conductors and considers only the sheath dc resistance when calculating λ_1 .

FM and FEM are employed in order to effectively represent proximity effects and appear to be in a good agreement each other. Both FM and FE models show a good agreement on eddy current loss (λ_1 " factor) with the existing analytical formulae for smaller conductors. When larger conductors are assumed, the discrepancy is kept fairly low on the condition that uniform current density in conductors is considered. The current distribution in conductors affects also solid bonding losses. Although λ_1 " factor is ignored by IEC 60287 for solidly bonded sheaths, it can overestimate conductor temperature by up to 7°C (8%), for cables with larger conductors. Even higher overestimation occurs if λ_1 " is added into IEC 60287 calculations. This is particularly important for projects which employ non-magnetically armored subsea cables. In subsea projects the use of Milliken conductors to reduce the proximity effect in conductors is technically challenging where waterblocking is needed.

Approximating formulae are derived based on the parametric study. The RFs are suitable for quick calculations and may be used in order to improve the accuracy of IEC Standard. Their application becomes important for conductor sizes of 1000 mm² and above and their thermal effect becomes higher when even larger sizes are considered.

VII. APPENDIX

Approximating formulae are suggested to improve the accuracy of the current $\lambda_{1,\text{IEC}}$ and $\lambda_{1,\text{IEC}}$ formulae used for three 1C cables in trefoil touching formation by IEC 60287. For both $\lambda_{1,\text{New}}$ and $\lambda_{1,\text{New}}$ in Lead sheaths the same form is extracted, though with different coefficients. The relevant reduction factors are given in (14) and (15) for 3rd order polynomial and linear approximation, respectively. The values for coefficients are illustrated in Table X, depending on bonding arrangement and approximating approach.

TABLE X
COEFFICIENTS FOR RF FORMULAE SUGGESTED FOR SPB AND SB LOSSES OF

 $RF_{lin}(r_C, X_{sc}) = p_{00} + p_{10} \cdot X_{sc} + p_{01} \cdot r_C$

	LEAD SHEATHED POWER CORES								
	Single-Point Bo	onding - $\lambda''_{1,\text{New}}$	Solid Bonding - $\lambda_{1,New}$						
Formula	(15)	(14)	(15)	(14)					
p_{00}	1.037	1.083	1.041	1.02					
p_{10}	8.125e-3	- 6.734e-3	0.00398	- 3.048e-3					
p_{01}	-0.0191	1.112e-3	- 0.0128	4.516e-3					
p_{20}	N/A	- 1.851e-4	N/A	- 1.133e-4					
p_{11}	N/A	1.585e-3	N/A	7.076e-4					
p_{02}	N/A	- 1.993e-3	N/A	- 1.258e-3					
p ₃₀	N/A	4.253e-6	N/A	2.956e-6					
p_{21}	N/A	-1.239e-5	N/A	- 8.957e-6					
p_{12}	N/A	- 1.325e-5	N/A	4.999e-8					
p_{03}	N/A	3.489e-5	N/A	1.828e-5					

VIII. ACKNOWLEDGMENT

D. Chatzipetros would like to thank his colleague and friend Dr. Andreas I. Chrysochos for his comments and suggestions in preparing this paper.

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X. BIOGRAPHIES



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